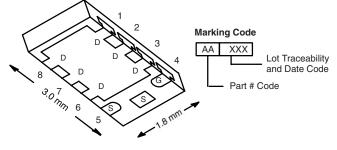


Vishay Siliconix

N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)		
60	0.034 at V _{GS} = 10 V	12	10.5 nC		
	0.041 at V _{GS} = 4.5 V	12	10.5110		

PowerPAK ChipFET Single



Bottom View

Ordering Information: Si5476DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm Profile

APPLICATIONS

- Load Switch for Portable Applications
- DC-DC Switch for Low Power Synchronous Rectification
- Intermediate Switch Driver for DC/DC Applications



COMPLIANT

S N-Channel MOSFET

G

D

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	60	v
Gate-Source Voltage		V _{GS}	± 20	v
	T _C = 25 °C		12 ^a	
Continuous Drain Current ($T_1 = 150 \ ^{\circ}C$)	T _C = 70 °C		12 ^a	7
Continuous Drain Current $(T_J = 150^{\circ}C)$	T _A = 25 °C	I _D	7 ^{b, c}	
	T _A = 70 °C		5.6 ^{b, c}	Α
Pulsed Drain Current		I _{DM}	25	A
Continuous Source Drain Diado Current	T _C = 25 °C	L.	12 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.6 ^{b, c}	
Avalanche Current	L = 0.1 mH	I _{AS}	15	
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	11.2	mJ
	T _C = 25 °C		31	
Maximum Power Dissipation	T _C = 70 °C	Р	20	w
	T _A = 25 °C	P _D	3.1 ^{b, c}	vv
	T _A = 70 °C		2 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150		
Soldering Recommendations (Peak Temperature) ^{d, e}			260	

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	$t \le 5 s$	R _{thJA}	34	40	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3	4	C/VV	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 90 °C/W.



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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 1 mA	60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 A		55		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.3			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$			1		
		V_{DS} = 60 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	25			Α	
Drain-Source On-State Resistance ^a		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4.6 \text{ A}$		0.028	0.034	Ω	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 4.2 \text{ A}$		0.033	0.041		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 4.6 A		20		S	
Dynamic ^b					I	1	
Input Capacitance	C _{iss}			1100		pF	
Output Capacitance	C _{oss}	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz		90			
Reverse Transfer Capacitance	C _{rss}			55			
		$V_{DS} = 30$ V, $V_{GS} = 10$ V, $I_{D} = 4.6$ A		21	32	nC	
Total Gate Charge	Qg			10.5	16		
Gate-Source Charge	Q _{gs}	V_{DS} = 30 V, V_{GS} = 4.5 V, I_{D} = 4.6 A		3.5			
Gate-Drain Charge	Q _{gd}			4.2			
Gate Resistance	R _g	f = 1 MHz		3.3		Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = 30 V, R_L = 5.4 Ω		150	225	- ns	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D} \cong 5.6$ A, V_GEN = 4.5 V, R_g = 1 Ω		20	30		
Fall Time	t _f			60	90		
Turn-On Delay Time	t _{d(on)}			10	15		
Rise Time	t _r	V_{DD} = 30 V, R_L = 5.4 Ω		15	25		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5.6$ A, V_{GEN} = 10 V, R_g = 1 Ω		22	40		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			12		
Pulse Diode Forward Current	I _{SM}				25	A	
Body Diode Voltage	V _{SD}	$I_{S} = 5.5 \text{ A}, V_{GS} = 0 \text{ V}$		0.85	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			25	50	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			25	50	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5.5 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$		19		1	
Reverse Recovery Rise Time	t _b	—		6		ns	

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



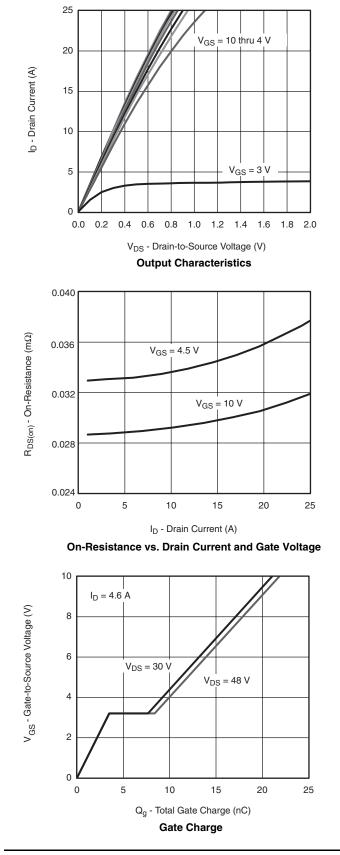
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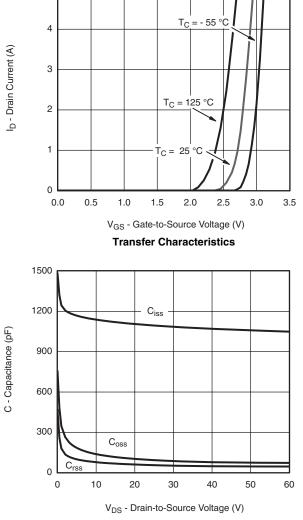


Si5476DU

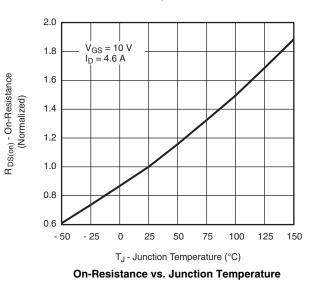
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





Capacitance

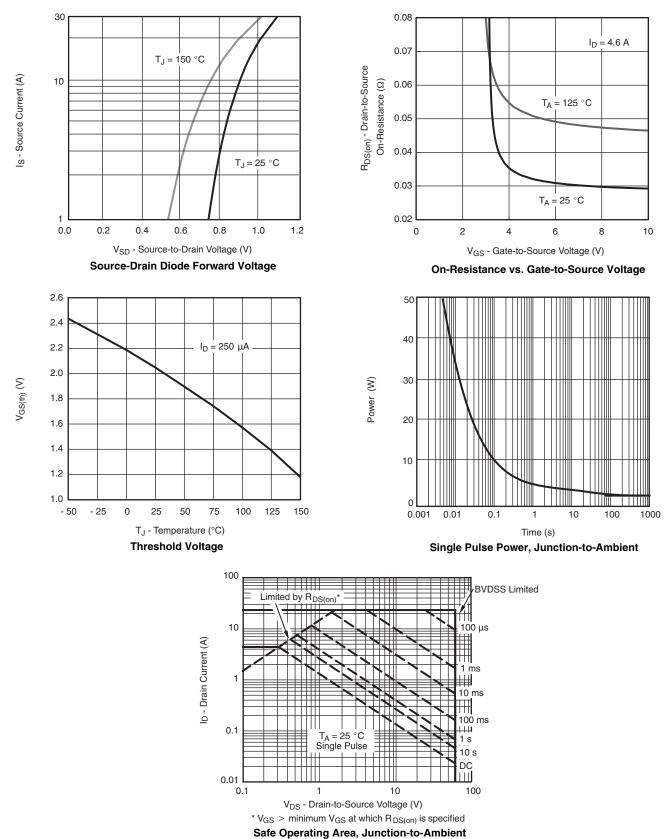


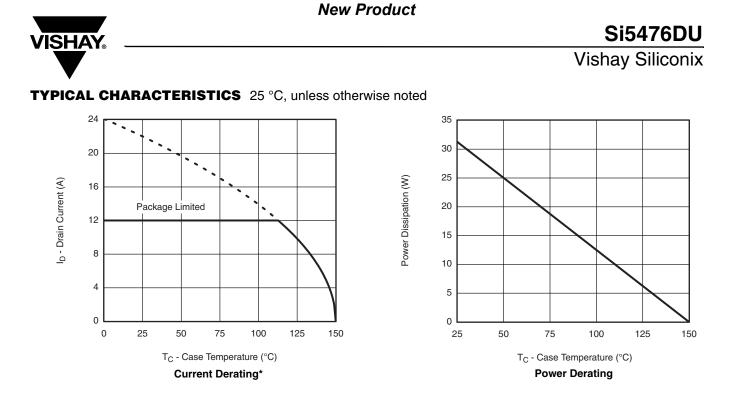
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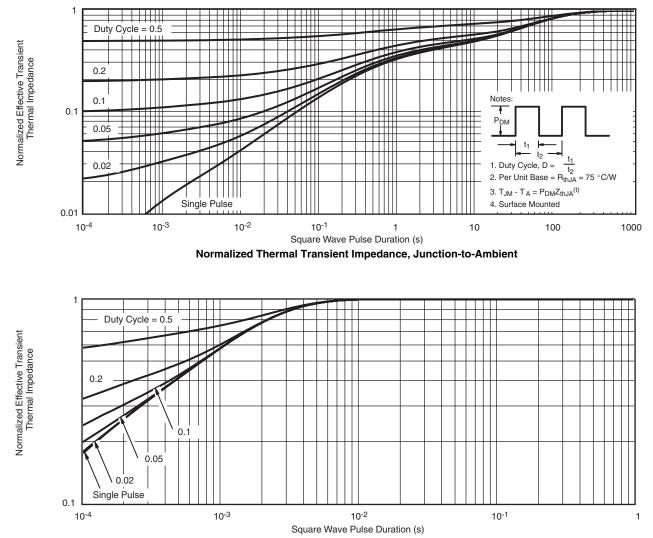


* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?73663.



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